

# MOSFET

Metal Oxide Semiconductor Field Effect Transistor

## OptiMOS™

OptiMOS™ Power-Transistor, 60 V  
IPA040N06N

## Data Sheet

Rev. 2.1  
Final

## 1 Description

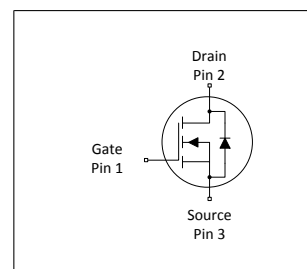
### Features

- Optimized for high performance SMPS, e.g. sync. rec.
- 100% avalanche tested
- Superior thermal resistance
- N-channel
- Qualified according to JEDEC<sup>1)</sup> for target applications
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21



**Table 1 Key Performance Parameters**

| Parameter        | Value | Unit |
|------------------|-------|------|
| $V_{DS}$         | 60    | V    |
| $R_{DS(on),max}$ | 4.0   | mΩ   |
| $I_D$            | 69    | A    |
| $Q_{OSS}$        | 44    | nC   |
| $Q_G(0V..10V)$   | 38    | nC   |



| Type / Ordering Code | Package     | Marking | Related Links |
|----------------------|-------------|---------|---------------|
| IPA040N06N           | PG-TO220-FP | 040N06N | -             |

<sup>1)</sup> J-STD20 and JESD22

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## 2 Maximum ratings

at  $T_j = 25\text{ °C}$ , unless otherwise specified

**Table 2 Maximum ratings**

| Parameter                                    | Symbol         | Values |      |          | Unit | Note / Test Condition                                                                   |
|----------------------------------------------|----------------|--------|------|----------|------|-----------------------------------------------------------------------------------------|
|                                              |                | Min.   | Typ. | Max.     |      |                                                                                         |
| Continuous drain current                     | $I_D$          | -      | -    | 69<br>48 | A    | $V_{GS}=10\text{ V}$ , $T_C=25\text{ °C}$<br>$V_{GS}=10\text{ V}$ , $T_C=100\text{ °C}$ |
| Pulsed drain current <sup>1)</sup>           | $I_{D,pulse}$  | -      | -    | 276      | A    | $T_C=25\text{ °C}$                                                                      |
| Avalanche energy, single pulse <sup>2)</sup> | $E_{AS}$       | -      | -    | 77       | mJ   | $I_D=69\text{ A}$ , $R_{GS}=25\text{ }\Omega$                                           |
| Gate source voltage                          | $V_{GS}$       | -20    | -    | 20       | V    | -                                                                                       |
| Power dissipation                            | $P_{tot}$      | -      | -    | 36       | W    | $T_C=25\text{ °C}$                                                                      |
| Operating and storage temperature            | $T_j, T_{stg}$ | -55    | -    | 175      | °C   | IEC climatic category;<br>DIN IEC 68-1: 55/175/56                                       |

## 3 Thermal characteristics

**Table 3 Thermal characteristics**

| Parameter                           | Symbol     | Values |      |      | Unit | Note / Test Condition |
|-------------------------------------|------------|--------|------|------|------|-----------------------|
|                                     |            | Min.   | Typ. | Max. |      |                       |
| Thermal resistance, junction - case | $R_{thJC}$ | -      | 3.1  | 4.2  | K/W  | -                     |

## 4 Electrical characteristics

**Table 4 Static characteristics**

| Parameter                        | Symbol        | Values |            |            | Unit          | Note / Test Condition                                                                                                               |
|----------------------------------|---------------|--------|------------|------------|---------------|-------------------------------------------------------------------------------------------------------------------------------------|
|                                  |               | Min.   | Typ.       | Max.       |               |                                                                                                                                     |
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | 60     | -          | -          | V             | $V_{GS}=0\text{ V}$ , $I_D=1\text{ mA}$                                                                                             |
| Gate threshold voltage           | $V_{GS(th)}$  | 2.1    | 2.8        | 3.3        | V             | $V_{DS}=V_{GS}$ , $I_D=50\text{ }\mu\text{A}$                                                                                       |
| Zero gate voltage drain current  | $I_{DSS}$     | -      | 0.1<br>10  | 1<br>100   | $\mu\text{A}$ | $V_{DS}=60\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=25\text{ °C}$<br>$V_{DS}=60\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=125\text{ °C}$ |
| Gate-source leakage current      | $I_{GSS}$     | -      | 10         | 100        | nA            | $V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$                                                                                          |
| Drain-source on-state resistance | $R_{DS(on)}$  | -      | 3.6<br>4.7 | 4.0<br>5.0 | m $\Omega$    | $V_{GS}=10\text{ V}$ , $I_D=69\text{ A}$<br>$V_{GS}=6\text{ V}$ , $I_D=18\text{ A}$                                                 |
| Gate resistance <sup>3)</sup>    | $R_G$         | -      | 1.3        | 1.95       | $\Omega$      | -                                                                                                                                   |
| Transconductance                 | $g_{fs}$      | 55     | 110        | -          | S             | $ V_{DS}  > 2 I_D /R_{DS(on)max}$ , $I_D=69\text{ A}$                                                                               |

<sup>1)</sup> See figure 3 for more detailed information

<sup>2)</sup> See figure 13 for more detailed information

<sup>3)</sup> Defined by design. Not subject to production test

**Table 5 Dynamic characteristics<sup>1)</sup>**

| Parameter                    | Symbol       | Values |      |      | Unit | Note / Test Condition                                                                         |
|------------------------------|--------------|--------|------|------|------|-----------------------------------------------------------------------------------------------|
|                              |              | Min.   | Typ. | Max. |      |                                                                                               |
| Input capacitance            | $C_{iss}$    | -      | 2700 | 3375 | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=30\text{ V}$ , $f=1\text{ MHz}$                                 |
| Output capacitance           | $C_{oss}$    | -      | 670  | 838  | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=30\text{ V}$ , $f=1\text{ MHz}$                                 |
| Reverse transfer capacitance | $C_{rss}$    | -      | 28   | 56   | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=30\text{ V}$ , $f=1\text{ MHz}$                                 |
| Turn-on delay time           | $t_{d(on)}$  | -      | 14   | -    | ns   | $V_{DD}=30\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=69\text{ A}$ , $R_{G,ext}=3\text{ }\Omega$ |
| Rise time                    | $t_r$        | -      | 16   | -    | ns   | $V_{DD}=30\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=69\text{ A}$ , $R_{G,ext}=3\text{ }\Omega$ |
| Turn-off delay time          | $t_{d(off)}$ | -      | 33   | -    | ns   | $V_{DD}=30\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=69\text{ A}$ , $R_{G,ext}=3\text{ }\Omega$ |
| Fall time                    | $t_f$        | -      | 8    | -    | ns   | $V_{DD}=30\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=69\text{ A}$ , $R_{G,ext}=3\text{ }\Omega$ |

**Table 6 Gate charge characteristics<sup>2)</sup>**

| Parameter                          | Symbol        | Values |      |      | Unit | Note / Test Condition                                                       |
|------------------------------------|---------------|--------|------|------|------|-----------------------------------------------------------------------------|
|                                    |               | Min.   | Typ. | Max. |      |                                                                             |
| Gate to source charge              | $Q_{gs}$      | -      | 13   | -    | nC   | $V_{DD}=30\text{ V}$ , $I_D=69\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate charge at threshold           | $Q_{g(th)}$   | -      | 8    | -    | nC   | $V_{DD}=30\text{ V}$ , $I_D=69\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate to drain charge <sup>1)</sup> | $Q_{gd}$      | -      | 7    | 9    | nC   | $V_{DD}=30\text{ V}$ , $I_D=69\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Switching charge                   | $Q_{sw}$      | -      | 13   | -    | nC   | $V_{DD}=30\text{ V}$ , $I_D=69\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate charge total                  | $Q_g$         | -      | 38   | 44   | nC   | $V_{DD}=30\text{ V}$ , $I_D=69\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate plateau voltage               | $V_{plateau}$ | -      | 4.8  | -    | V    | $V_{DD}=30\text{ V}$ , $I_D=69\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate charge total, sync. FET       | $Q_{g(sync)}$ | -      | 33   | -    | nC   | $V_{DS}=0.1\text{ V}$ , $V_{GS}=0\text{ to }10\text{ V}$                    |
| Output charge <sup>1)</sup>        | $Q_{oss}$     | -      | 44   | 55   | nC   | $V_{DD}=30\text{ V}$ , $V_{GS}=0\text{ V}$                                  |

**Table 7 Reverse diode**

| Parameter                             | Symbol        | Values |      |      | Unit | Note / Test Condition                                                      |
|---------------------------------------|---------------|--------|------|------|------|----------------------------------------------------------------------------|
|                                       |               | Min.   | Typ. | Max. |      |                                                                            |
| Diode continuous forward current      | $I_S$         | -      | -    | 30   | A    | $T_C=25\text{ }^\circ\text{C}$                                             |
| Diode pulse current                   | $I_{S,pulse}$ | -      | -    | 276  | A    | $T_C=25\text{ }^\circ\text{C}$                                             |
| Diode forward voltage                 | $V_{SD}$      | -      | 0.88 | 1.2  | V    | $V_{GS}=0\text{ V}$ , $I_F=30\text{ A}$ , $T_J=25\text{ }^\circ\text{C}$   |
| Reverse recovery time <sup>1)</sup>   | $t_{rr}$      | -      | 33   | 53   | ns   | $V_R=30\text{ V}$ , $I_F=30\text{ A}$ , $di_F/dt=100\text{ A}/\mu\text{s}$ |
| Reverse recovery charge <sup>1)</sup> | $Q_{rr}$      | -      | 28   | -    | nC   | $V_R=30\text{ V}$ , $I_F=30\text{ A}$ , $di_F/dt=100\text{ A}/\mu\text{s}$ |

<sup>1)</sup> Defined by design. Not subject to production test

<sup>2)</sup> See "Gate charge waveforms" for parameter definition

## 5 Electrical characteristics diagrams

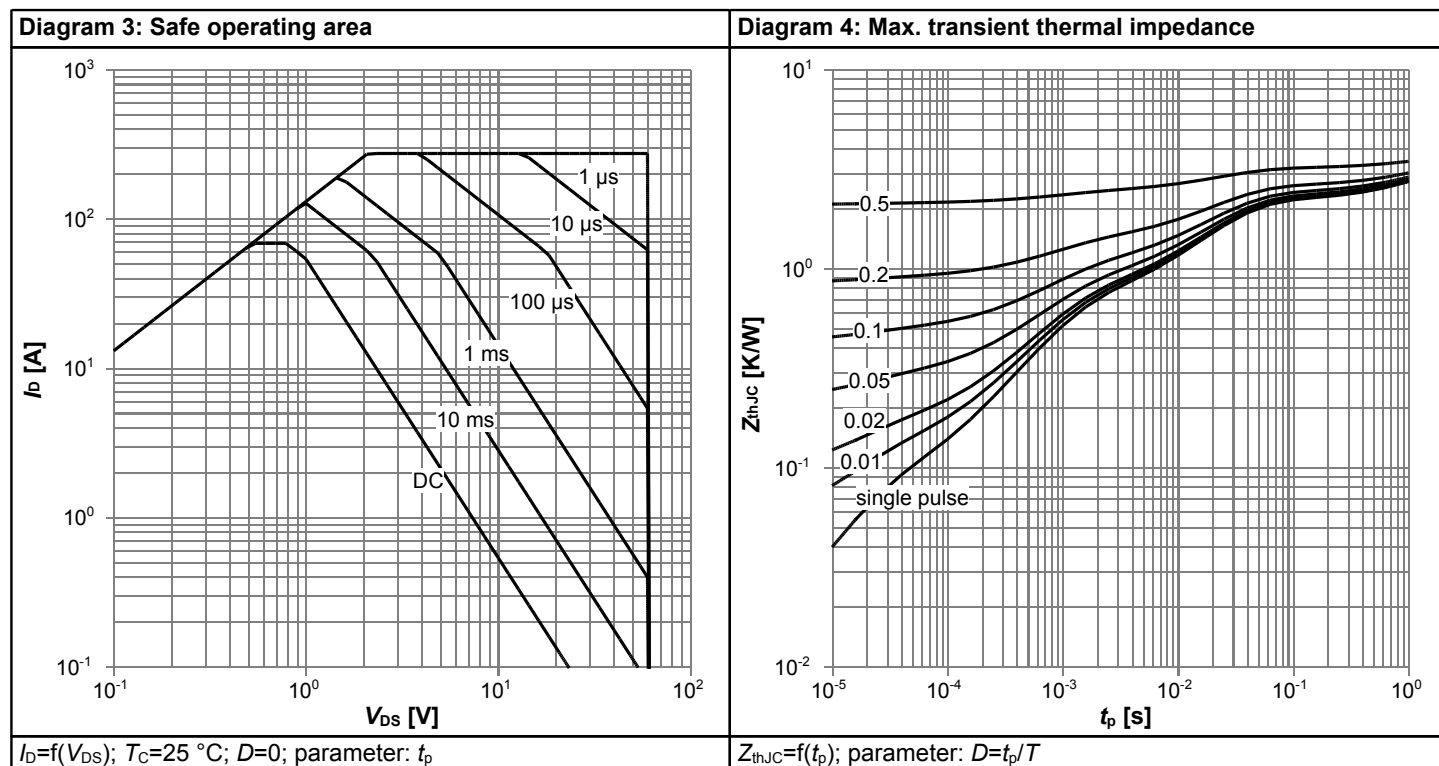
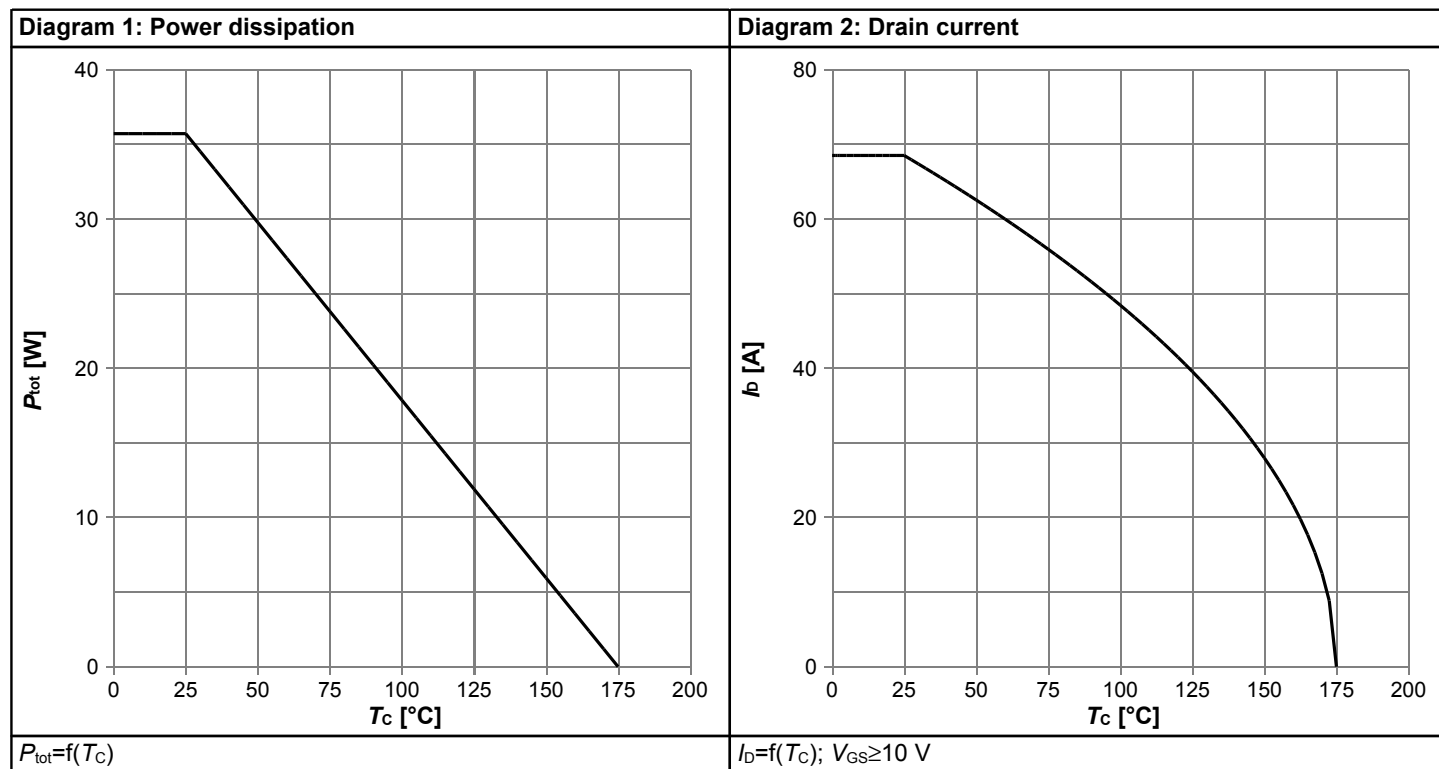


Diagram 5: Typ. output characteristics

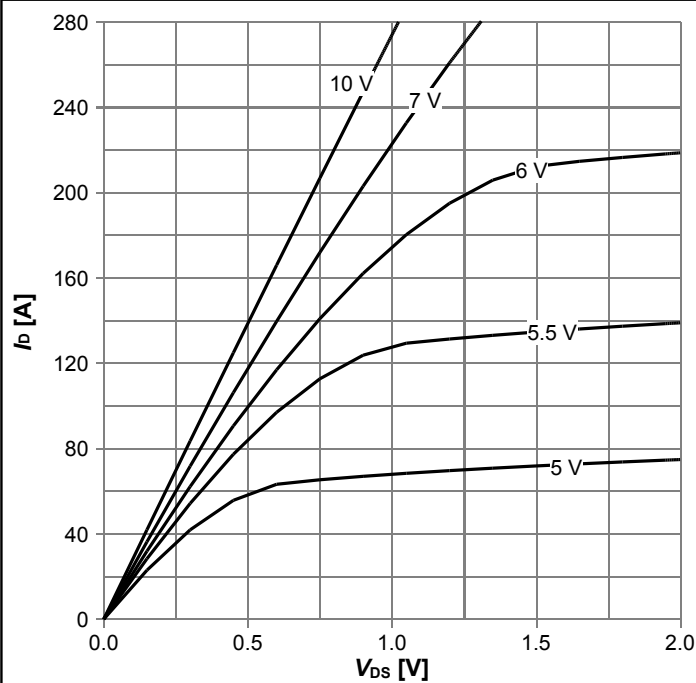

 $I_D = f(V_{DS}); T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$ 

Diagram 6: Typ. drain-source on resistance

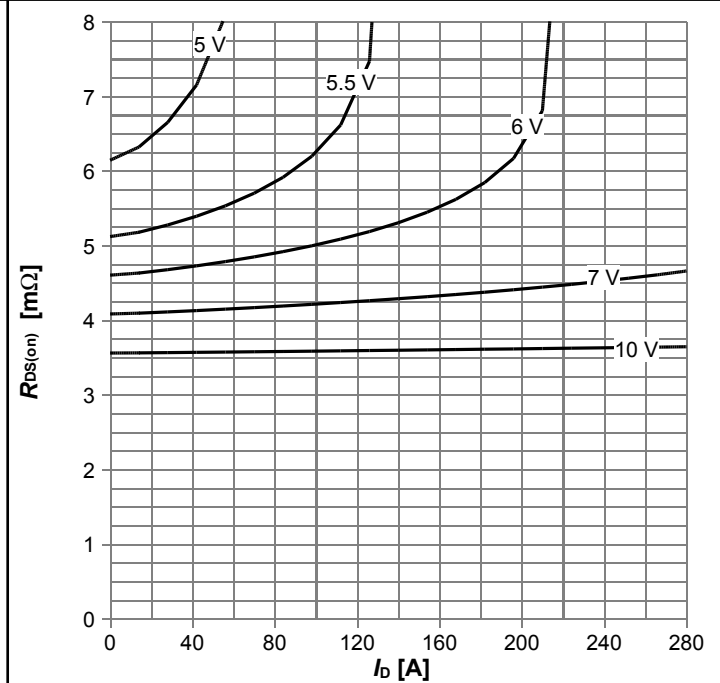

 $R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$ 

Diagram 7: Typ. transfer characteristics

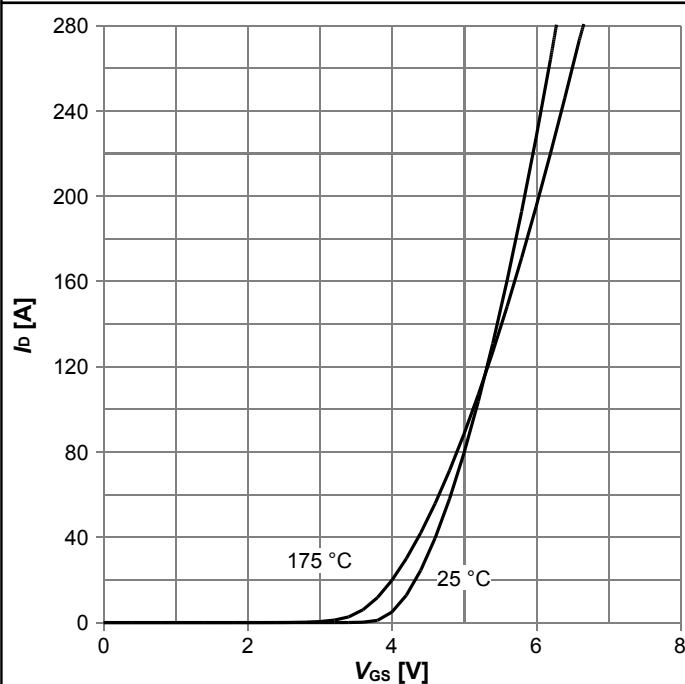

 $I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}; \text{parameter: } T_j$ 

Diagram 8: Typ. forward transconductance

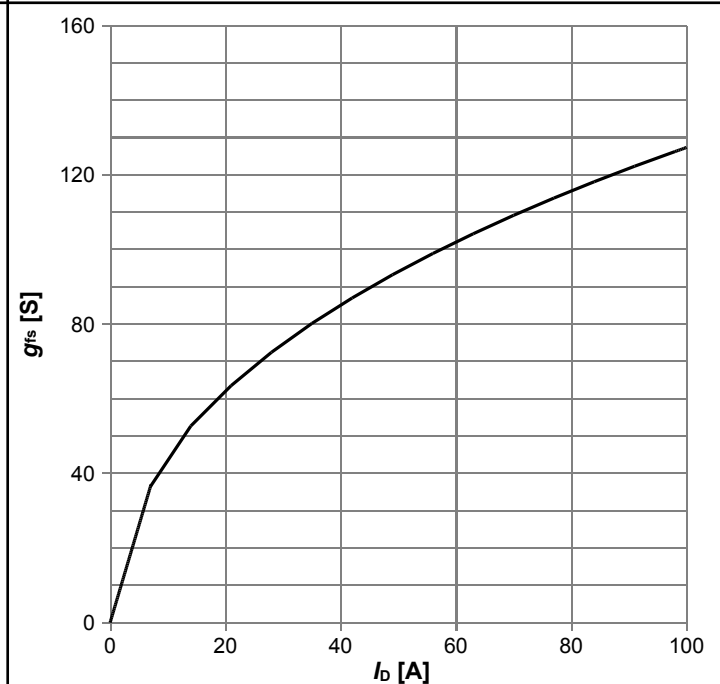
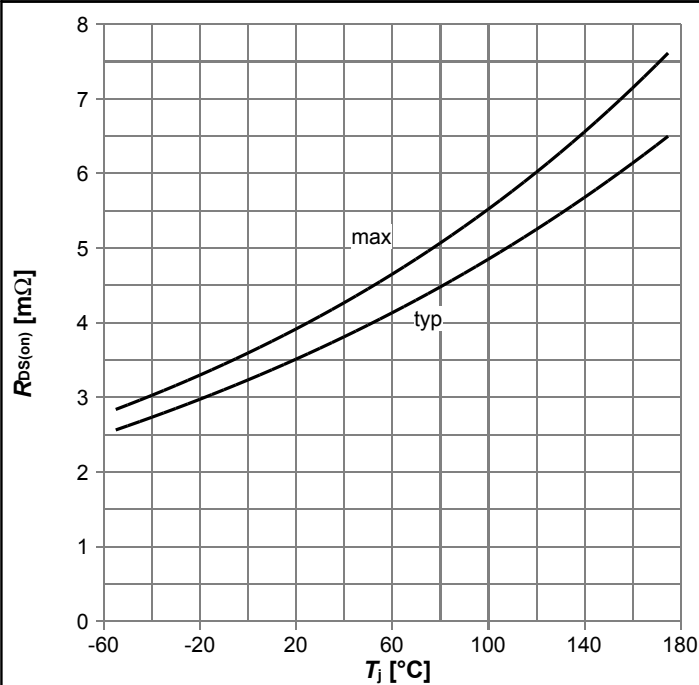
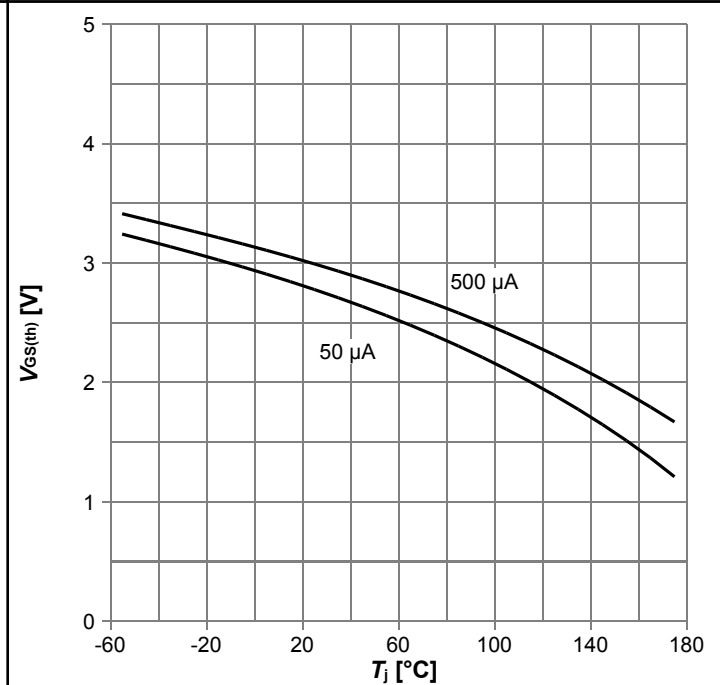

 $g_{fs} = f(I_D); T_j = 25^\circ\text{C}$

Diagram 9: Drain-source on-state resistance



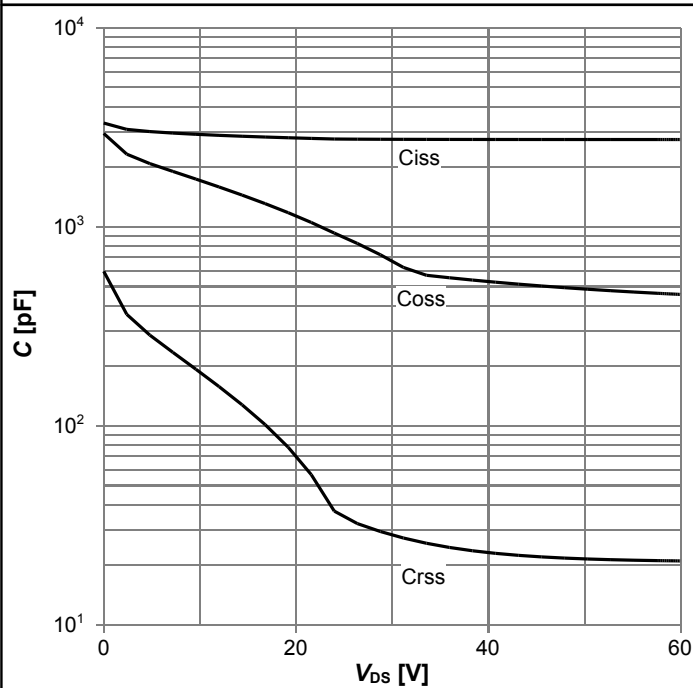
$$R_{DS(on)} = f(T_j); I_D = 69 \text{ A}; V_{GS} = 10 \text{ V}$$

Diagram 10: Typ. gate threshold voltage



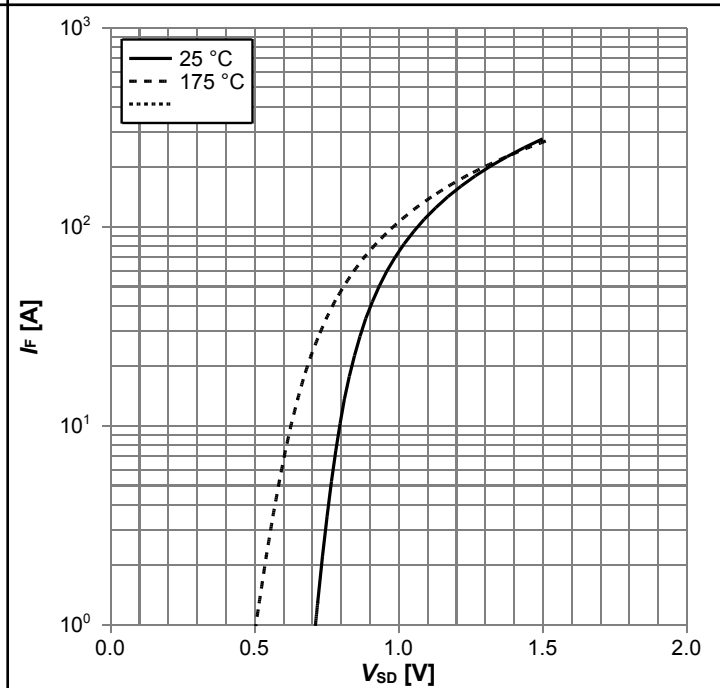
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$$

Diagram 11: Typ. capacitances



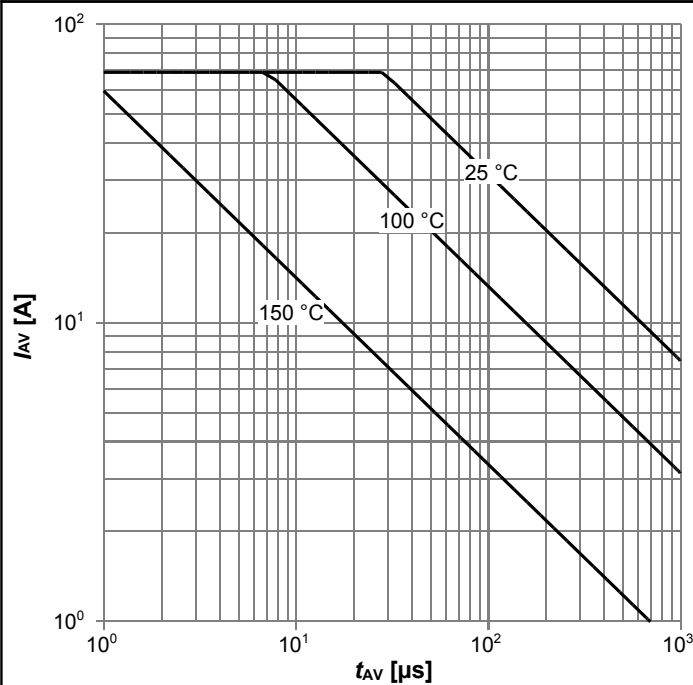
$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$

Diagram 12: Forward characteristics of reverse diode



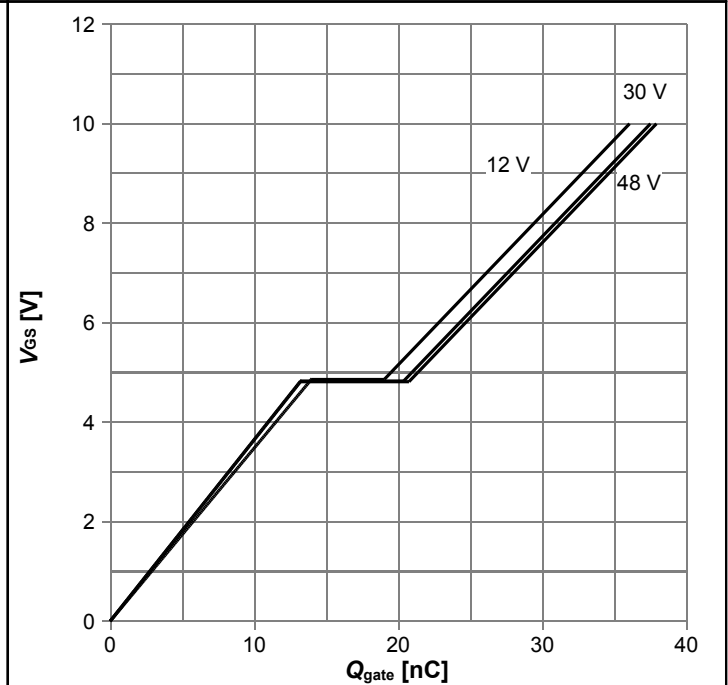
$$I_F = f(V_{SD}); \text{parameter: } T_j$$

**Diagram 13: Avalanche characteristics**



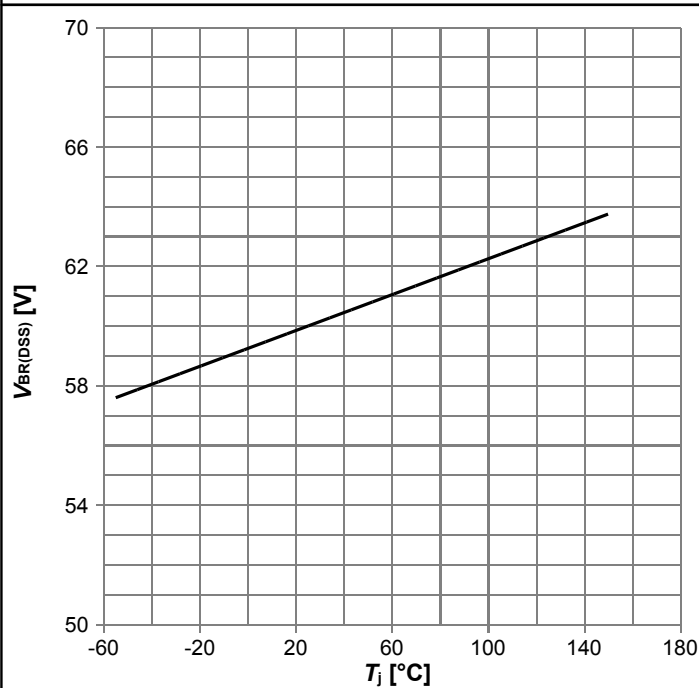
$I_{AS}=f(t_{AV})$ ;  $R_{GS}=25\ \Omega$ ; parameter:  $T_{j(start)}$

**Diagram 14: Typ. gate charge**



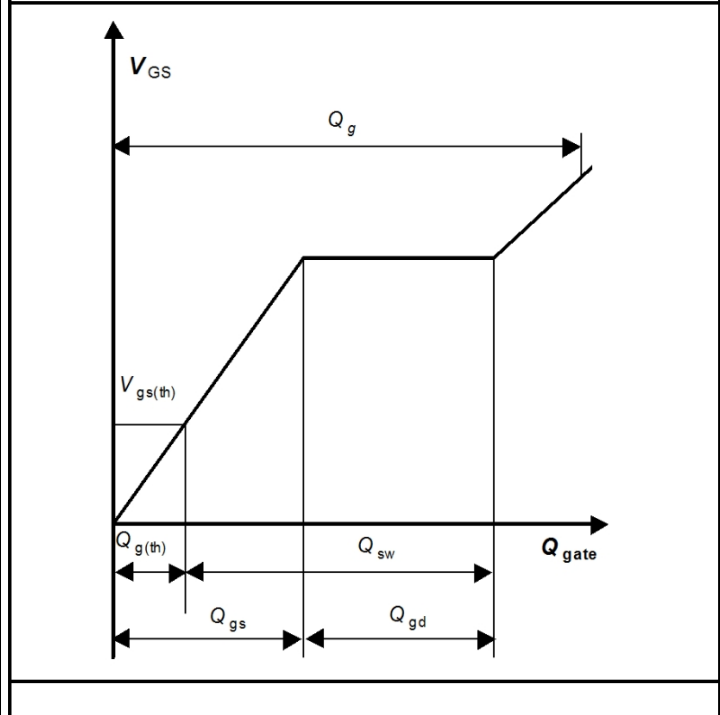
$V_{GS}=f(Q_{gate})$ ;  $I_D=69\text{ A}$  pulsed; parameter:  $V_{DD}$

**Diagram 15: Drain-source breakdown voltage**

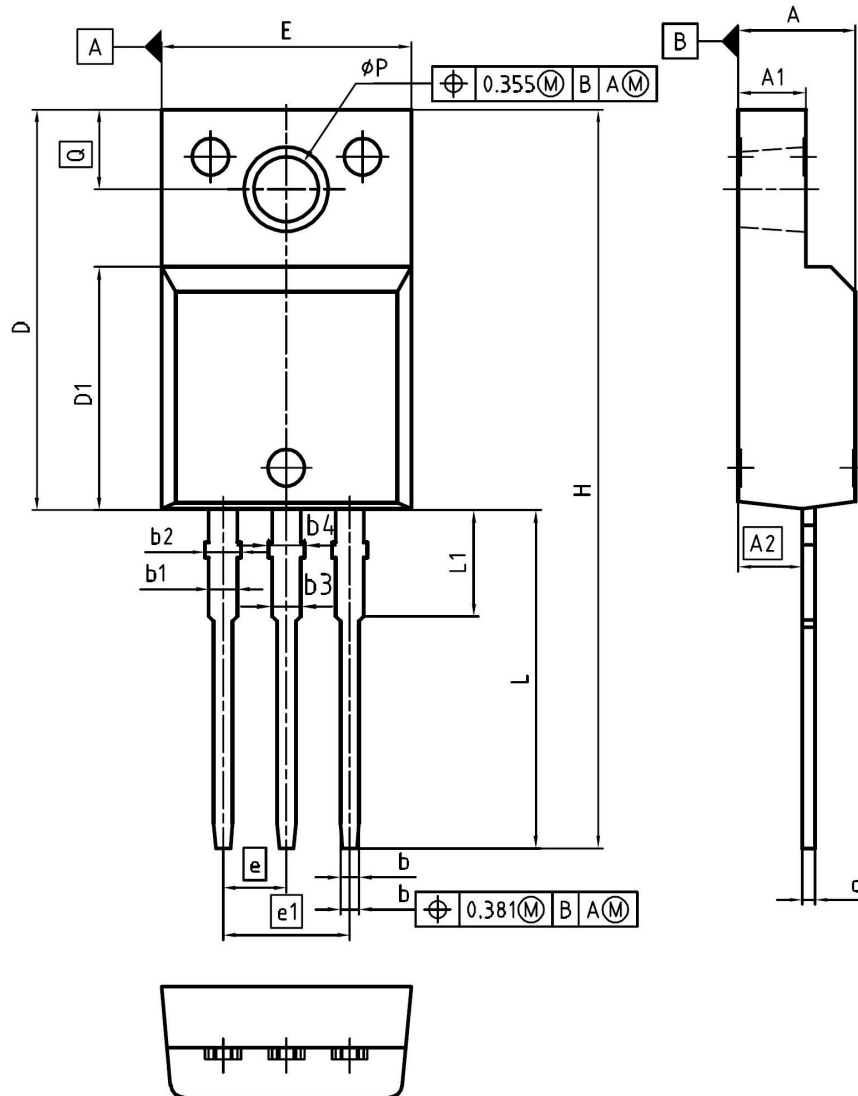


$V_{BR(DSS)}=f(T_J)$ ;  $I_D=1\text{ mA}$

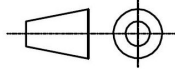
**Gate charge waveforms**



## 6 Package Outlines



| DIM | MILLIMETERS |       | INCHES |       |
|-----|-------------|-------|--------|-------|
|     | MIN         | MAX   | MIN    | MAX   |
| A   | 4.55        | 4.85  | 0.179  | 0.191 |
| A1  | 2.55        | 2.85  | 0.100  | 0.112 |
| A2  | 2.42        | 2.72  | 0.095  | 0.107 |
| b   | 0.65        | 0.85  | 0.026  | 0.033 |
| b1  | 0.95        | 1.33  | 0.037  | 0.052 |
| b2  | 0.95        | 1.51  | 0.037  | 0.059 |
| b3  | 0.65        | 1.33  | 0.026  | 0.052 |
| b4  | 0.65        | 1.51  | 0.026  | 0.059 |
| c   | 0.40        | 0.63  | 0.016  | 0.025 |
| D   | 15.85       | 16.15 | 0.624  | 0.636 |
| D1  | 9.53        | 9.83  | 0.375  | 0.387 |
| E   | 10.35       | 10.65 | 0.407  | 0.419 |
| e   | 2.54        |       | 0.100  |       |
| e1  | 5.08        |       | 0.200  |       |
| N   | 3           |       | 3      |       |
| H   | 29.45       | 29.75 | 1.159  | 1.171 |
| L   | 13.45       | 13.75 | 0.530  | 0.541 |
| L1  | 3.15        | 3.45  | 0.124  | 0.136 |
| øP  | 2.95        | 3.20  | 0.116  | 0.126 |
| Q   | 3.15        | 3.50  | 0.124  | 0.138 |

|                                                                                                              |
|--------------------------------------------------------------------------------------------------------------|
| DOCUMENT NO.<br>Z8B00003319                                                                                  |
| SCALE<br>0 2.5 5mm                                                                                           |
| EUROPEAN PROJECTION<br> |
| ISSUE DATE<br>08-03-2007                                                                                     |
| REVISION<br>03                                                                                               |

**Figure 1 Outline PG-TO220-FP, dimensions in mm/inches**

## Revision History

IPA040N06N

**Revision: 2014-06-19, Rev. 2.1**

Previous Revision

| Revision | Date       | Subjects (major changes since last revision) |
|----------|------------|----------------------------------------------|
| 2.1      | 2014-06-19 | Rev.2.1                                      |

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